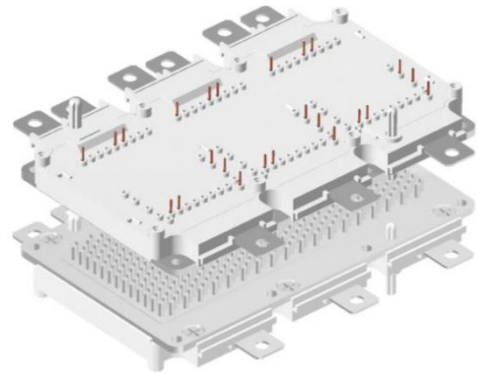


HPD IGBT Power Module

$V_{CES}=750V$, $I_C=820A$, $V_{CE(sat)}=1.40V$

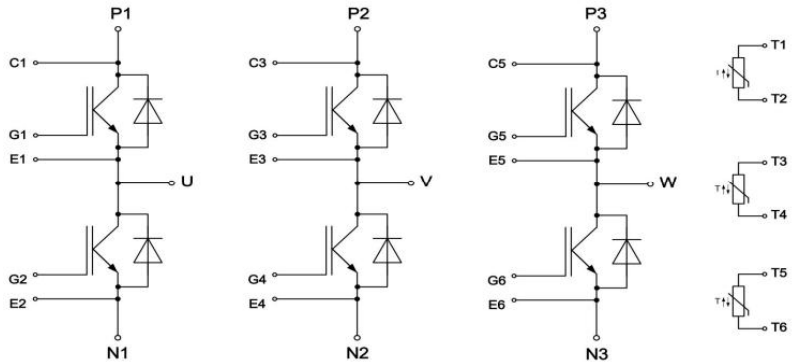
Features

- 750V Trench and Field Stop technology
- High short circuit capability
- High Power Density
- Low conduction and switching losses
- V_{cesat} positive temperature coefficient
- Fast & soft recovery anti-parallel FRD
- Integrated NTC temperature sensor



Applications

- Motor Drives
- Hybrid Electrical Vehicles (H)EV
- Commercial Agriculture Vehicles



IGBT, Inverter Maximum Ratings

Parameter	Symbol	Test Condition	Value	Unit
Collector-emitter voltage	V_{CES}	$T_{vj}=25^{\circ}C$, $V_{GE}=0V$	750	V
Implemented collector current	I_{CN}		820	A
Continuous DC collector current	$I_{C\ nom}$	$T_F=70^{\circ}C$, $T_{vj\ max}=175^{\circ}C$	450 ¹⁾	A
Repetitive peak collector current	I_{CRM}	$t_p=1ms$, $T_{vj}=25^{\circ}C$	1640	A
Gate-emitter peak voltage	V_{GES}	$T_{vj}=25^{\circ}C$	± 30	V
SC data	I_{SC}	$V_{GE}\leq 15V$, $V_{CC}=400V$, $V_{CEmax}=V_{CES}-L_sCE*di/dt$, $t_p\leq 5\mu s$, $T_{vj}=150^{\circ}C$	4000	A
Total power dissipation	P_{tot}	$T_F=85^{\circ}C$, $T_{vj\ max}=175^{\circ}C$	692 ¹⁾	W

Characteristics Values

Parameter	Symbol	Test Condition	Value			Unit
			min.	typ.	max.	
Collector-emitter saturation voltage	V_{CEsat}	$I_C=450A$, $V_{GE}=15V$, $T_{vj}=25^{\circ}C$		1.40	1.60	V
		$I_C=450A$, $V_{GE}=15V$, $T_{vj}=150^{\circ}C$		1.50		
		$I_C=450A$, $V_{GE}=15V$, $T_{vj}=175^{\circ}C$		1.51		
		$I_C=800A$, $V_{GE}=15V$, $T_{vj}=25^{\circ}C$		1.79		
		$I_C=800A$, $V_{GE}=15V$, $T_{vj}=175^{\circ}C$		2.0		

Gate-emitter threshold voltage	V_{GEth}	$V_{CE}=V_{GE}$, $I_C=10mA$	$T_{vj}=25^{\circ}C$	5.0	5.8	6.5	V
			$T_{vj}=175^{\circ}C$		4.0		
Gate charge	Q_G	$V_{GE}=-8V...+15V$, $V_{CE} = 400V$			4.3		μC
Integrated gate resistor	R_{Gint}	$T_{vj}=25^{\circ}C$			1		Ω
Input capacitance	C_{ies}	$T_{vj}=25^{\circ}C$, $f=100KHz$, $V_{GE}=0V$, $V_{CE}=25V$			38		nF
Output capacitance	C_{oes}	$T_{vj}=25^{\circ}C$, $f=100KHz$, $V_{GE}=0V$, $V_{CE}=25V$			1.82		
Reverse transfer capacitance	C_{res}	$T_{vj}=25^{\circ}C$, $f=100KHz$, $V_{GE}=0V$, $V_{CE}=25V$			0.23		
Collector-emitter cut-off current	I_{CES}	$V_{CE}=750V$, $V_{GE}=0V$	$T_{vj}=25^{\circ}C$			1	mA
			$T_{vj}=175^{\circ}C$		4		
Gate-emitter leakage current	I_{GES}	$V_{CE}=0V$, $V_{GE}=20V$, $T_{vj}=25^{\circ}C$				400	nA
Turn-on delay time, inductive load	t_{don}	$I_C=450A$, $V_{CE}=400V$, $V_{GE}=-8V/+15V$, $R_{Gon}=5\Omega$, $R_{Goff}=5\Omega$	$T_{vj}=25^{\circ}C$		248		ns
			$T_{vj}=150^{\circ}C$		255		
			$T_{vj}=175^{\circ}C$		265		
Rise time, inductive load	t_r		$T_{vj}=25^{\circ}C$		88		
			$T_{vj}=150^{\circ}C$		101		
			$T_{vj}=175^{\circ}C$		105		
Turn-off delay time, inductive load	t_{doff}		$T_{vj}=25^{\circ}C$		509		
			$T_{vj}=150^{\circ}C$		662		
			$T_{vj}=175^{\circ}C$		670		
Fall time, inductive load	t_f	$T_{vj}=25^{\circ}C$		111			
		$T_{vj}=150^{\circ}C$		122			
		$T_{vj}=175^{\circ}C$		130			
Turn-on energy loss per pulse	E_{on}	$I_C=450A$, $V_{CE}=400V$, $V_{GE}=-8V/+15V$, $R_{Gon}=5\Omega$, $L_s=20nH$, $di/dt(T_{vj}25^{\circ}C)=4300A/\mu s$,	$T_{vj}=25^{\circ}C$		16.5		mJ
			$T_{vj}=150^{\circ}C$		20.5		
			$T_{vj}=175^{\circ}C$		21.9		
Turn-off energy loss per pulse	E_{off}	$I_C=450A$, $V_{CE}=400V$, $V_{GE}=-8V/+15V$, $R_{Goff}=5\Omega$, $L_s=20nH$, $dv/dt(T_{vj}25^{\circ}C)=7100V/\mu s$	$T_{vj}=25^{\circ}C$		22.2		mJ
			$T_{vj}=150^{\circ}C$		27.5		
			$T_{vj}=175^{\circ}C$		28.7		
IGBT, thermal resistance, junction to cooling fluid	R_{thjF} IGBT	per IGBT, $\Delta V/ \Delta t=10dm^3/min$, $T_F=75^{\circ}C$			0.11	0.13	K/W
Temperature under switching conditions	T_{vjop}	top continuous for 10s within a period of 30s, occurrence maximum 3000 times over lifetime		-40 150		150 ²⁾ 175	$^{\circ}C$

1) Verified by characterization / design not by test.

2) For $T_{vjop} > 150^{\circ}C$: Baseplate temperature has to be limited to $125^{\circ}C$.

Diode, Inverter
Maximum Ratings

Parameter	Symbol	Test Condition	Value	Unit
Repetitive peak reverse voltage	V_{RRM}	$T_{vj}=25^{\circ}\text{C}$	750	V
Implemented forward current	I_{FN}		820	A
Continuous DC forward current	I_F		450 ¹⁾	A
Repetitive peak forward current	I_{FRM}	$t_p=1\text{ms}$	1640	A
I^2t -value	I^2t	$V_R=0\text{V}, t_p=10\text{ms}, T_{vj}=150^{\circ}\text{C}$	18000	A^2s
		$V_R=0\text{V}, t_p=10\text{ms}, T_{vj}=175^{\circ}\text{C}$	15500	A^2s

Characteristics Values

Parameter	Symbol	Test Condition	Value			Unit	
			min.	typ.	max.		
Forward voltage	V_F	$I_F=450\text{A}, V_{GE}=0\text{V}$	$T_{vj}=25^{\circ}\text{C}$		1.3	1.6	V
		$I_F=450\text{A}, V_{GE}=0\text{V}$	$T_{vj}=150^{\circ}\text{C}$		1.28		V
		$I_F=450\text{A}, V_{GE}=0\text{V}$	$T_{vj}=175^{\circ}\text{C}$		1.27		V
		$I_F=800\text{A}, V_{GE}=0\text{V}$	$T_{vj}=25^{\circ}\text{C}$		1.56		V
		$I_F=800\text{A}, V_{GE}=0\text{V}$	$T_{vj}=175^{\circ}\text{C}$		1.58		V
Peak reverse recovery current	I_{RM}		$T_{vj}=25^{\circ}\text{C}$		195		A
			$T_{vj}=150^{\circ}\text{C}$		300		A
			$T_{vj}=175^{\circ}\text{C}$		320		A
Recovered charge	Q_r	$I_F=450\text{A}, V_R=400\text{V}, V_{GE}=-8\text{V}, -di_F/dt=5000\text{A}/\mu\text{s} (T_{vj}=25^{\circ}\text{C})$	$T_{vj}=25^{\circ}\text{C}$		12.17		μC
			$T_{vj}=150^{\circ}\text{C}$		29.5		μC
			$T_{vj}=175^{\circ}\text{C}$		37.2		μC
Reverse recovery energy	E_{rec}		$T_{vj}=25^{\circ}\text{C}$		3.7		mJ
			$T_{vj}=150^{\circ}\text{C}$		6.8		mJ
			$T_{vj}=175^{\circ}\text{C}$		7.4		mJ
Diode, thermal resistance, junction to cooling fluid	R_{thjF} Diode	per diode, $\Delta V/\Delta t=10\text{dm}^3/\text{min}, T_F=75^{\circ}\text{C}$		0.17	0.19		K/W
Temperature under switching conditions	$T_{vj op}$	top continuous for 10s within a period of 30s, occurrence maximum 3000times over lifetime	-40 150		150 ²⁾ 175		$^{\circ}\text{C}$

1) Verified by characterization / design not by test.

2) For $T_{vj op} > 150^{\circ}\text{C}$: Baseplate temperature has to be limited to 125°C .

NTC-Thermistor

Parameter	Symbol	Test Condition	Value			Unit
			min.	typ.	max.	
Rated resistance	R_{25}	$T_C=25^{\circ}\text{C}$		5.0		K Ω
Deviation of R100	$\Delta R/R$	$T_C=100^{\circ}\text{C}, R_{100}=493\Omega$	-3		3	%
Power dissipation	P_{25}	$T_C=25^{\circ}\text{C}$			20	mW
B-value	$B_{25/50}$	$R_2=R_{25} \exp[B_{25/50}/(1/T_2-1/(298.15\text{K}))]$		3375		K

B-value	B _{25/80}	$R_2=R_{25}$ $\exp[B_{25/80}(1/T_2-1/(298.15K))]$		3411		K
B-value	B _{25/100}	$R_2=R_{25} \exp$ $[B_{25/100}(1/T_2-1/(298.15K))]$		3433		K

Specification according to the valid application note.

Characteristics Values(Module)

Parameter	Symbol	Test Condition	Value			Unit
			min.	typ.	max.	
Storage temperature	T _{stg}		-40		150	°C
Stray inductance module	L _{sCE}			7		nH
Module lead resistance, terminals - chip	R _{CC'+EE}	T _{vj} =25°C, per switch		0.9		mΩ
Isolation test voltage	V _{isol}	Ac, RMS, f=50Hz, t=1min		3.5		kV
Maximum RMS module terminal current	I _{tRMS}	T _F =75°C, T _{ct} =105°C		500		A
Creepage distance	d _{Creep}	Terminal to terminal		9.0		mm
		Terminal to heat sink		9.0		mm
Clearance distance in air	d _{Clear}	Terminal to terminal		4.5		mm
		Terminal to heat sink		4.5		mm
Comparative tracking index	CTI		>200			
Mounting torque for module mounting	M1	Screw M4 base plate to heat sink	1.8	2.0	2.2	N·m
	M2	Screw M4 EJOT Delta PCB to frame	0.45	0.50	0.55	
Terminal connection torque	M3	Screw M5	3		6	
Material of module base plate	-		Cu+Ni ¹⁾			-
Internal isolation	-	Basic insulation (class1, IEC61140)	Al ₂ O ₃ ²⁾			-
Pressure drop in cooling circuit	Δp	ΔV/Δt =10.0 dm ³ /min; T _F =75°C		64		mbar
Maximum pressure in cooling circuit	p	T _{base plate} < 40°C			2.5	bar
		T _{base plat} > 40°C (relative pressure)			2.0	
Dimensions	LxWxH		154.5x126.5x32			mm
Weight	G		720			g

- 1) Ni-plated Cu baseplate.
- 2) Improved Al₂O₃ ceramic.

Typical Characteristics

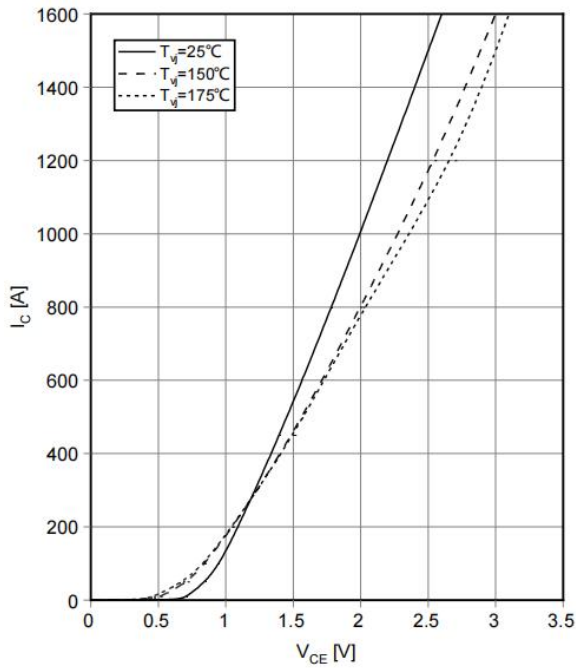


Fig 1. Output characteristic IGBT, Inverter(typical)
 $I_c=f(V_{CE}), V_{GE}=15\text{V}$

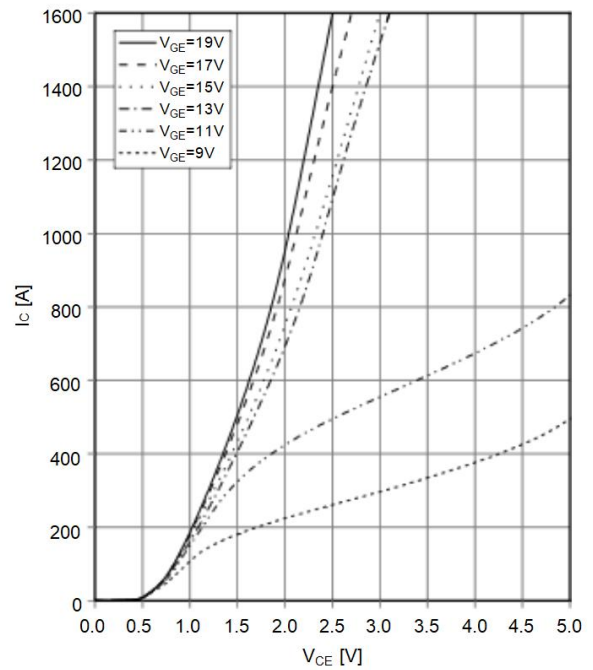


Fig 2. Output characteristic IGBT, Inverter(typical)
 $I_c=f(V_{CE}), T_{vj}=150^\circ\text{C}$

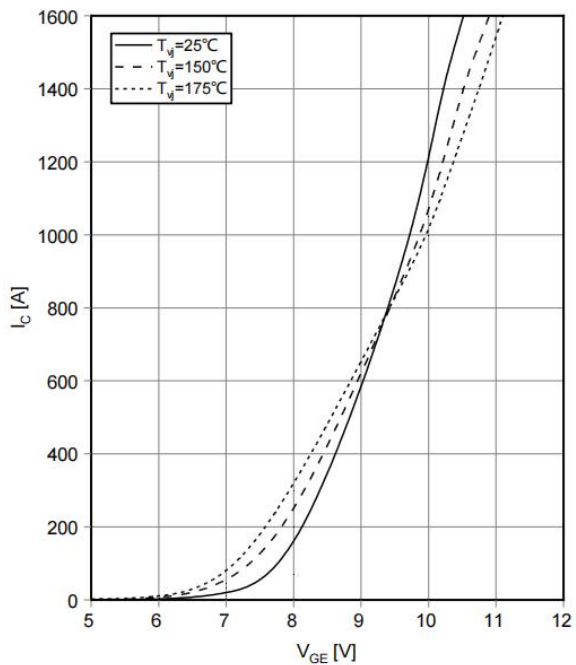


Fig 3. Transfer characteristic IGBT, Inverter(typical)
 $I_c=f(V_{GE}), V_{CE}=20\text{V}$

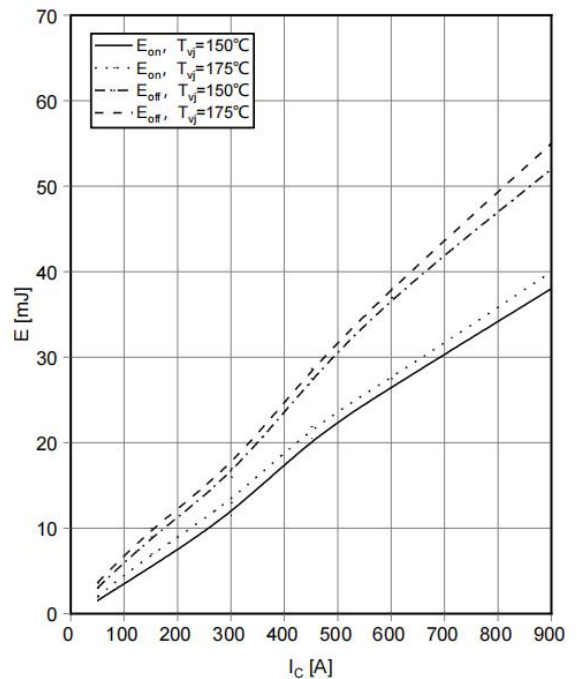


Fig 4. Switching losses IGBT, Inverter(typical)
 $E_{on}=f(I_c), E_{off}=f(I_c), V_{GE}=-8\text{V}/+15\text{V}, R_{Gon}=R_{Goff}=5\Omega, V_{CE}=400\text{V}$

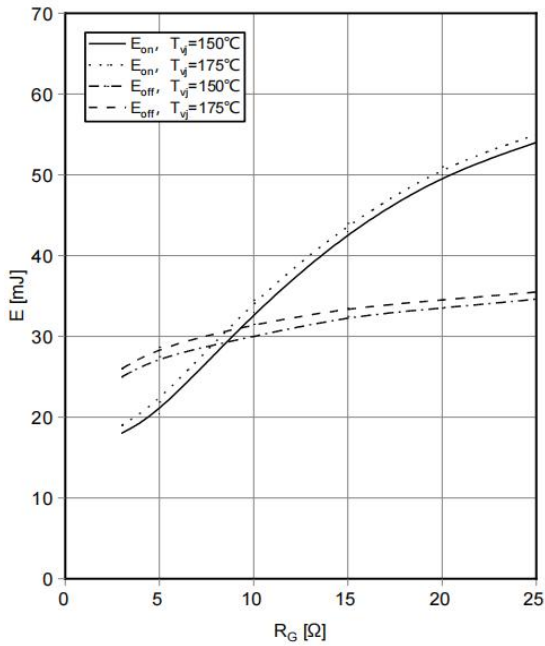


Fig 5. Switching losses IGBT, Inverter(typical) $E_{on}=f(R_G)$, $E_{off}=f(R_G)$ $V_{GE}=-8V/+15V$, $I_C=450A$, $V_{CE}=400V$

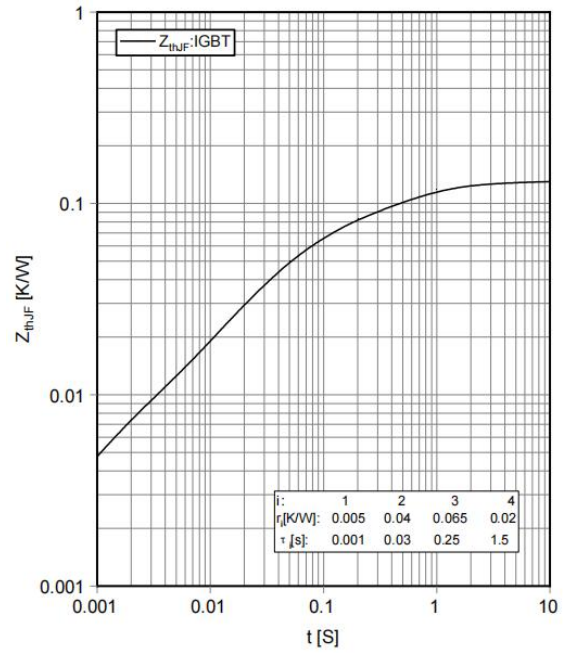


Fig 6. Transient thermal impedance IGBT, Inverter $Z_{thJF}=f(t)$

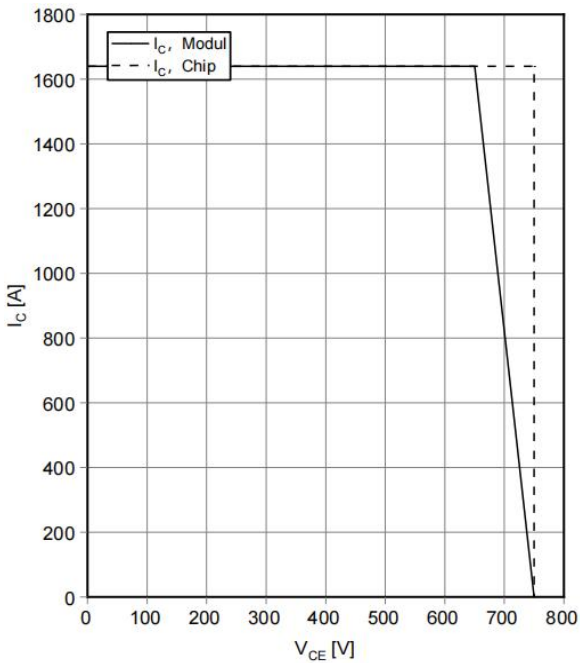


Fig 7. Reverse bias safe operating area IGBT, Inverter(RBSOA) $I_C=f(V_{CE})$, $V_{GE}=+15V/-8V$, $R_{Goff}=5\Omega$, $T_{vj}=175^\circ C$

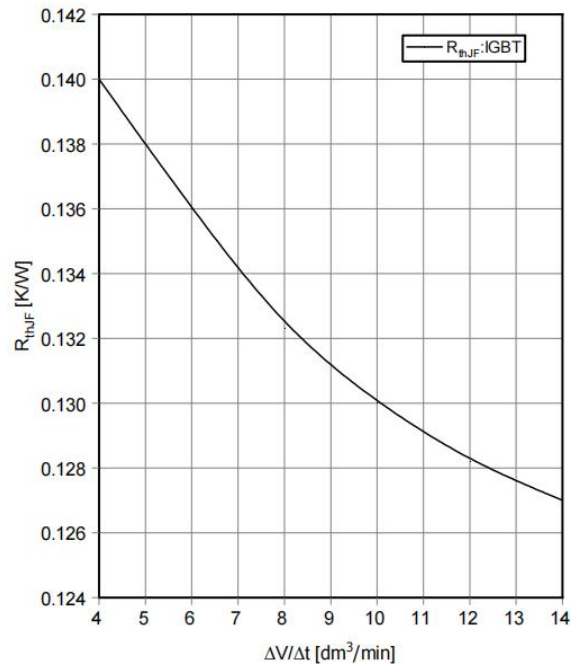


Fig 8. Thermal impedance IGBT, Inverter $R_{thJF}=f(\Delta V/\Delta t)$, $T_f=75^\circ C$; 50% water/50% ethylene glycol

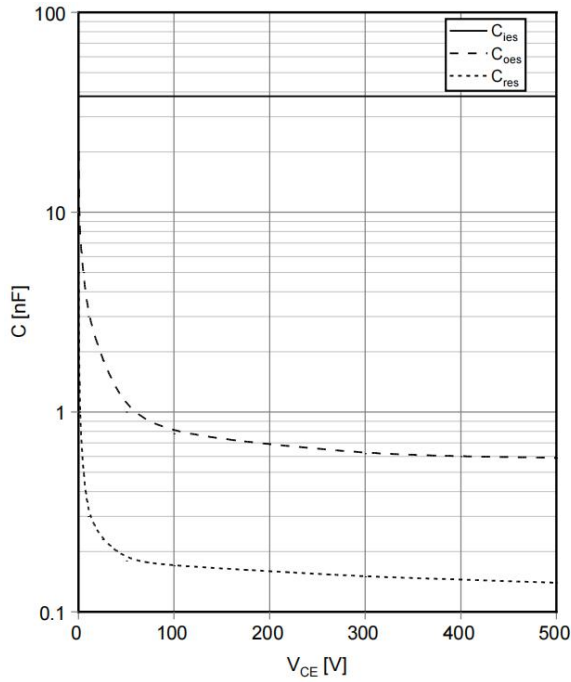


Fig 9. Capacity characteristic IGBT, Inverter(typical)
 $C=f(V_{CE})$, $V_{GE}=0V$, $T_{vj}=25^{\circ}C$, $f=100KHz$

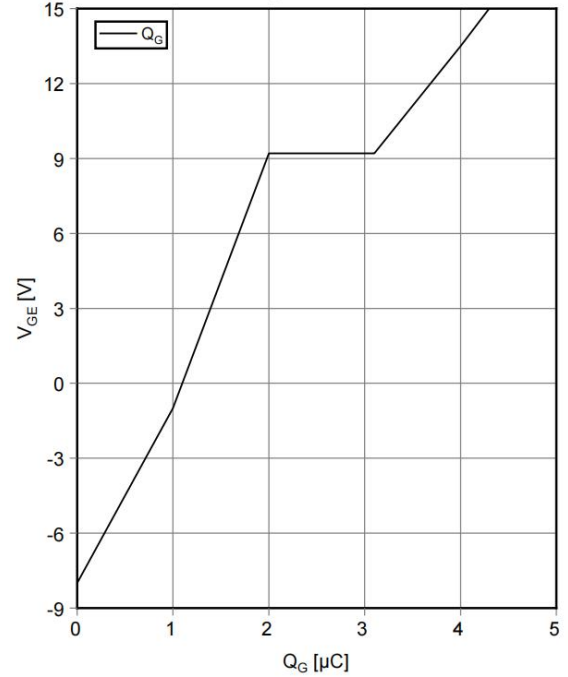


Fig 10. Gate charge characteristic IGBT, Inverter(typical)
 $V_{GE}=f(Q_G)$, $V_{CE}=400V$, $I_C=450A$, $T_{vj}=25^{\circ}C$

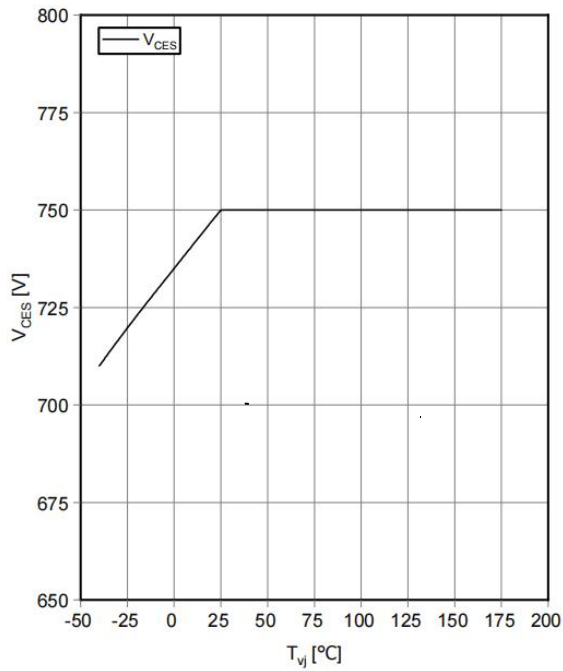


Fig 11. Maximum allowed collector-emitter voltage $V_{CES}=f(T_{vj})$, verified by characterization/design not by test.
 $I_{CES}=1mA$ for $T_{vj} \leq 25^{\circ}C$; $I_{CES}=30mA$ for $T_{vj} > 25^{\circ}C$

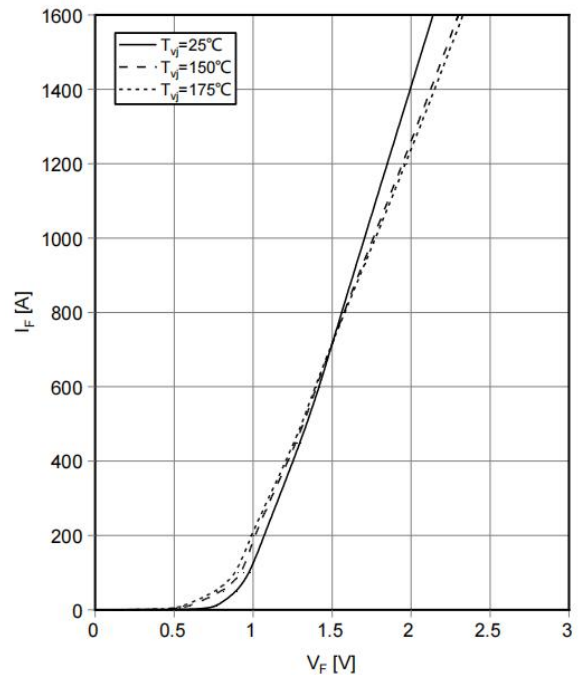


Fig 12. Forward characteristic of FRD, Inverter(typical)
 $I_F=f(V_F)$

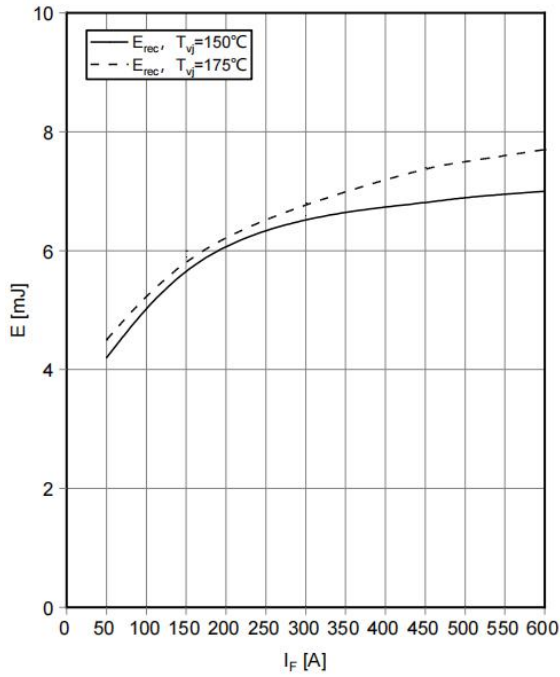


Fig 13. Switching losses FRD, Inverter(typical)
 $E_{rec}=f(I_F)$, $R_{Gon}=5\Omega$, $V_{CE}=400V$

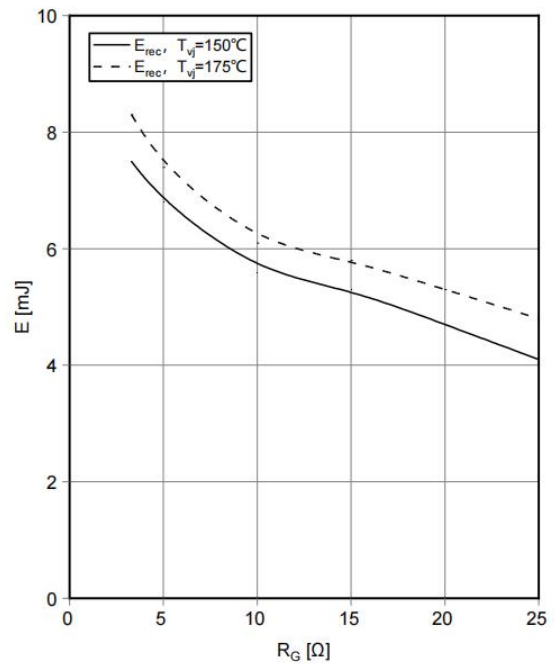


Fig 14. Switching losses FRD, Inverter(typical)
 $E_{rec}=f(R_G)$, $I_F=450A$, $V_{CE}=400V$

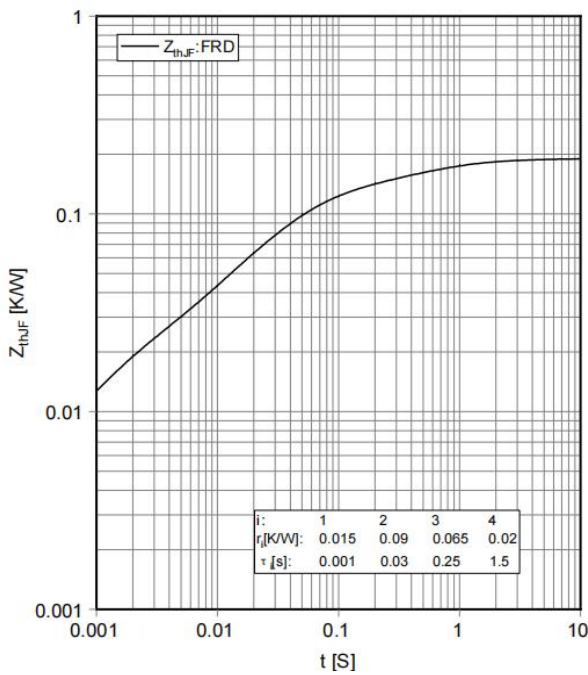


Fig 15. Transient thermal impedance FRD, Inverter
 $Z_{thJF}=f(t)$
 $\Delta V/\Delta t=10dm^3/min$; $T_f=75^\circ C$; 50% water/50% ethylene glycol

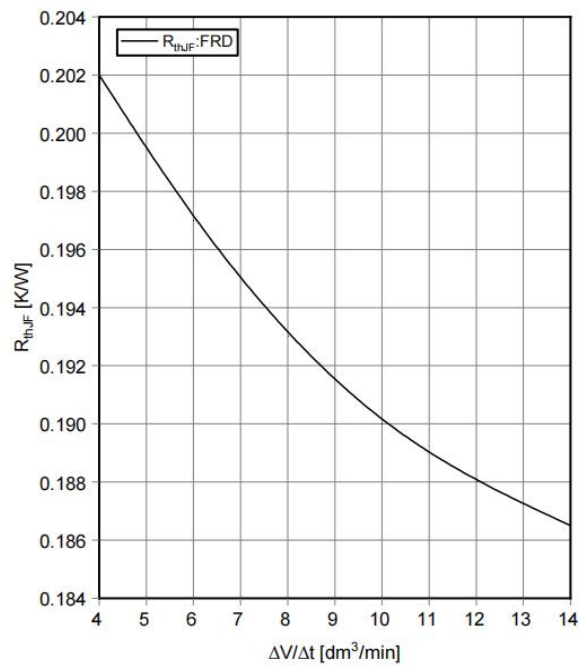


Fig 16. Thermal impedance FRD, Inverter
 $R_{thJF}=f(\Delta V/\Delta t)$, $T_f=75^\circ C$; 50% water / 50% ethylene glycol

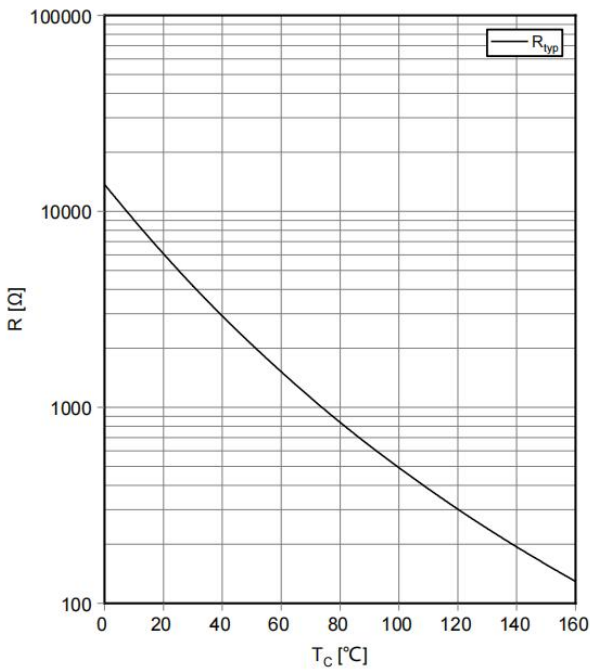


Fig 17. NTC Thermistor temperature, characteristic (typical)
 $R=f(T)$

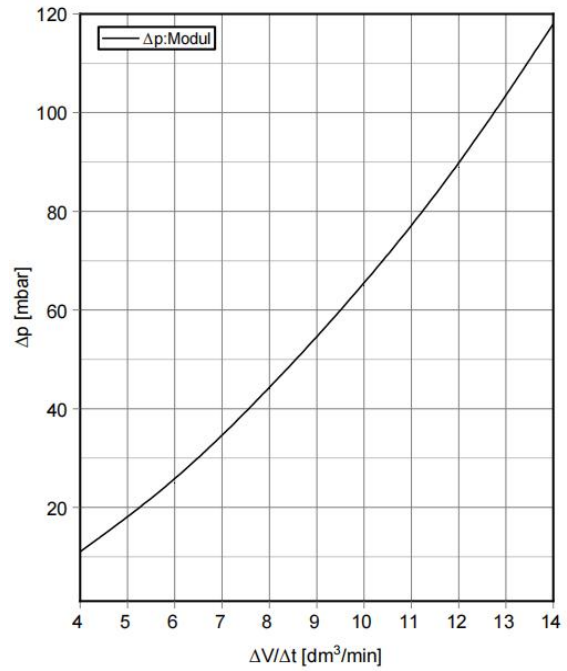
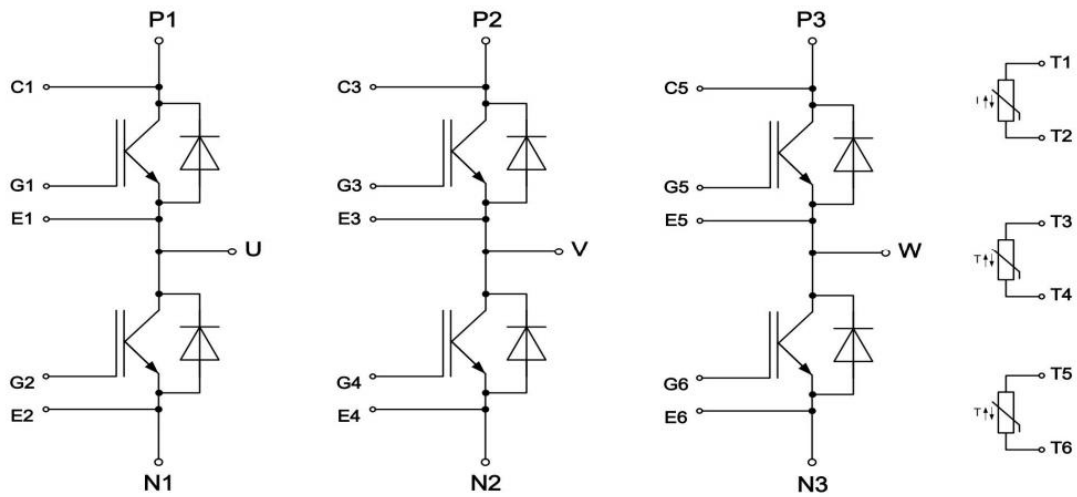


Fig 18. Pressure drop in cooling circuit
 $\Delta p = f(\Delta V/\Delta t)$, $T_F=75^\circ\text{C}$; 50% water / 50% ethylene glycol

Circuit Diagram



***Important Usage Information and Disclaimer**

The specifications of Zhuhai Hypersemi Co., Ltd. products are not guarantees of product characteristics. They reflect typical performance expected in standard applications, which may vary with specific uses. Users must conduct prior testing for their applications and make necessary adjustments.

Users are responsible for the safety of applications utilizing our products and must implement adequate safety measures to prevent physical injury, fire, or other risks in case of product failure. It is the user's duty to ensure that application designs comply with all applicable laws and standards. Our products must not be used in any applications where a product failure could reasonably result in personal injury, unless specifically authorized in a signed document by Zhuhai Hypersemi Co., Ltd.

No representations or warranties are made regarding the accuracy or completeness of this information, including any claims of non-infringement of third-party intellectual property rights. Zhuhai Hypersemi Co., Ltd. assumes no liability for any applications or uses of its products and does not grant any licenses to its intellectual property rights or those of others. We also make no claims regarding non-infringement of third-party intellectual property rights that may arise from applications.

Due to technical requirements, our products may contain hazardous substances. For details, please contact your nearest sales office. This document replaces all previous information and may be updated. We reserve the right to make changes.